

Application/Control No.	Applicant(s)/Patent under Reexamination	pplicant(s)/Patent under dexamination	
10/699,452	JIANG ET AL.		
Examiner	Art Unit		
James D. Ewart	2683		

SEARCHED					
Class	Subclass	Date	Examiner		
455	67.11	8/9/2005	JDE		
	115.1				
	418				
	419				
	450				
	452				
	453				
	455	"			
	509				
	561				
370	431				
	439				
	443				
	464				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		*		
	1			